

SHARP

PC4SD11series

PC4SD21series

Under development

New product

Phototriac Coupler

V_{DRM} :800V Phototriac Coupler for Triggering

Features

- (1) Repetitive peak OFF-state voltage(V_{DRM}):800V
- (2) Low zero-cross voltage ($V_{OX[MAX]}$ =20 V)
- (3) Line up for each trigger current
- (4) Recognized by UL, file No. E64380
- (5) Approved by CSA file No. CA95323
- (6) Approved by VDE0884 file No127413 (as an option)

Applications

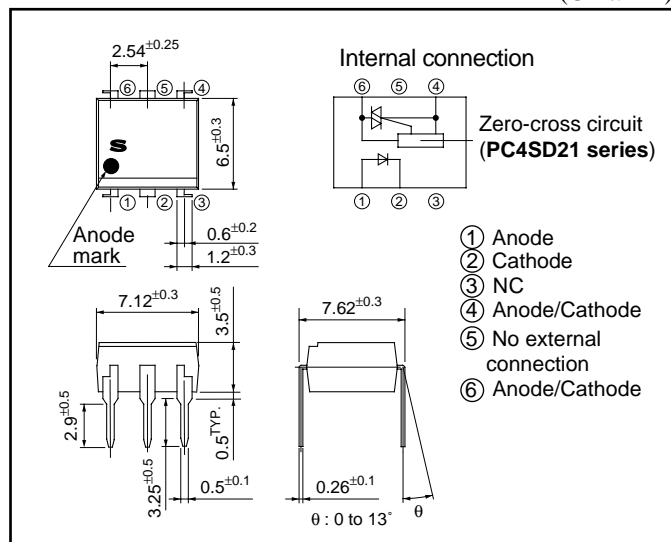
- (1) Home appliances
- (2) OA equipment, FA equipment
- (3) SSRs

Model Line-up

	for AC 200V line
No zero-cross circuit	PC4SD11NTZB ($I_{FT[MAX]}$ = 7 mA)
	PC4SD11NTZC ($I_{FT[MAX]}$ = 5 mA)
Built-in zero-cross circuit	PC4SD21NTZC ($I_{FT[MAX]}$ = 5 mA)
	PC4SD21NTZD ($I_{FT[MAX]}$ = 3 mA)

Outline Dimensions

(Unit:mm)



Absolute Maximum Ratings

($T_a=25^{\circ}C$)

Parameter		Symbol	Ratings	Unit
Input	Forward current	I_F	50	mA
	Reverse voltage	V_R	6	V
Output	RMS ON-state current	$I_{T(rms)}$	100	mA
	*1 Peak one cycle surge current	I_{surge}	1.2	A
	Repetitive peak OFF-state voltage	V_{DRM}	800	V
	*2 Isolation voltage	$V_{iso(rms)}$	5.0	kV
Operating temperature		T_{opr}	-30 to +100	$^{\circ}C$
Storage temperature		T_{stg}	-40 to +125	$^{\circ}C$
*3 Soldering temperature		T_{sol}	260	$^{\circ}C$

*1: 50Hz sine wave

*2: AC for 1 minute, RH=40 to 60%, f=60Hz

*3: For 10s

(Notice)

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(Internet)

- Data for Sharp's optoelectronic/power devices is provided on internet. (Address <http://sharp-world.com/ecg/>)

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Phototriac Coupler

Electro-optical Characteristics

(Ta=25°C)

Parameter			Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Input	Forward voltage		V _F	I _F =20 mA	-	1.2	1.4	V
	Reverse current		I _R	V _R =3 V	-	-	10	μA
Output	Repetitive peak OFF-state current		I _{DRM}	V _D =V _{DRM}	-	-	3	μA
	ON-state voltage		V _T	I _T =100 mA	-	-	2.5	V
	Holding current		I _H	V _D =6 V (Built-in zero-cross circuit type: V _D =4 V)	0.1	-	3.5	mA
	Critical rate of rise of OFF-state voltage	PC4SD11NTZB	dV/dt	V _D =1/√2 • V _{DRM}	50	-	-	V/μs
		PC4SD11NTZC			500	1000	-	
		PC4SD21NTZC						
	Zero-cross voltage		V _{OX}	Resistance load, I _F =8 mA	-	-	20	V
Transfer characteristics	Minimum trigger current	PC4SD11NTZB	I _{FT}	V _D =6 V (Built-in zero-cross circuit type : V _D =4 V), R _L =100 Ω	-	-	7	mA
		PC4SD11NTZC			-	-	5	
		PC4SD21NTZC			-	-	3	
		PC4SD21NTZD			-	-	3	
	Isolation resistance		R _{ISO}	DC500 V, 40 to 60%RH	5×10 ¹⁰	1×10 ¹¹	-	Ω
	Turn-on time	PC4SD11NTZB	t _{on}	V _D =6 V, R _L =100 Ω, I _F =20 mA	-	-	100	μs
		PC4SD11NTZC		V _D =4 V, R _L =100 Ω, I _F =20 mA	-	-	50	
		PC4SD21NTZC		V _D =4 V, R _L =100 Ω, I _F =20 mA	-	-	50	

As of September 2001

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 - Telecommunication equipment [terminal]
 - Test and measurement equipment
 - Industrial control
 - Audio visual equipment
 - Consumer electronics
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 - Traffic signals
 - Gas leakage sensor breakers
 - Alarm equipment
 - Various safety devices, etc.
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